



Electro Optical Components, Inc.

5464 Skylane Boulevard, Suite D, Santa Rosa, CA 95403

Toll Free: 855-EOC-6300

www.eoc-inc.com | info@eoc-inc.com



CCSMHx09x MEMS Micro-hotplate

MICRO-HOTPLATE (250µm Diameter)

Benefits and Features

- High stability + High temperature
- Built-in FET & temp-sensing diode option
- Gold electrodes option
- Fast thermal response <15ms
- Lifetime @ 550°C >10 years
- Power consumption <0.12mW/°C (without sensing material)

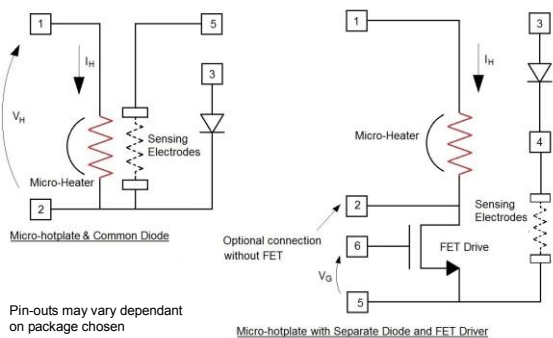
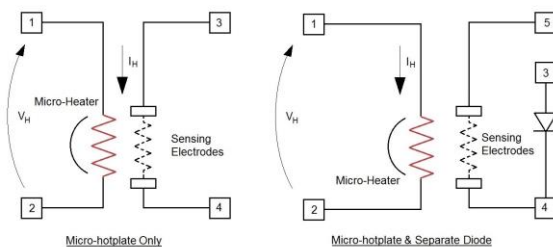
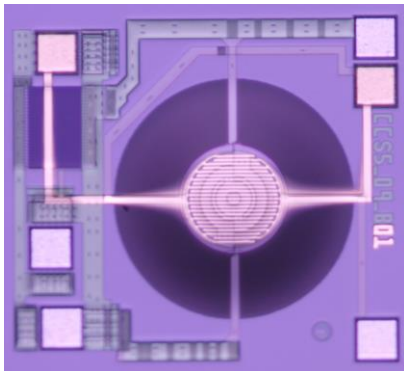
Sensing Applications

- Resistive & Catalytic gases
- Medical
- Humidity
- Flow
- Multiple gases
- Micro-heating element

Packaging Options

- Bare Die
- SMD
- Micro TO
- TO46
- TO39
- Array versions also available.

MEMS CMOS Micro-Hotplate for Gas Sensing



Pin-outs may vary dependant on package chosen

Micro-hotplate with Separate Diode and FET Driver

Description

Basic high temperature micro-hotplate where the heater temperature can be controlled by appropriately adjusting the current or the supply voltage. The device is fabricated on a 1mm x 1mm silicon die as a single-chip solution and can incorporate a temperature-sensing diode and/or FET driver. Gold sensing electrodes are on top of the membrane.

Electrical/Optical specifications

Parameter	Nominal Value
Power Consumption(DC) at 600°C	72mW ± 7mW
Thermal Rise Time (t_{90})	15ms ± 5ms
Thermal Fall Time (t_{10})	30ms ± 5ms
Operating Temperature	600°C
Ambient Resistance (R_0)	40Ω ± 10Ω
Heater Resistance ^{Note1} (R) @ 600°C	80Ω ± 20Ω
Heater Voltage (V_H) @ 600°C	2.4V ± 0.3V
Heater Current (I_H) @ 600°C	30mA ± 4mA
Diode Temp Coefficient (d) @ 65µA	1.3mV/K
Sensing Area	0.05mm ² min
Life Time (MTTF) @ 600°C ^{Note2}	~ 50000 Hours

Note1

$$1: R = (R_0 - R_T)[1 + \alpha(T - T_0) + \beta(T - T_0)^2] + R_T$$

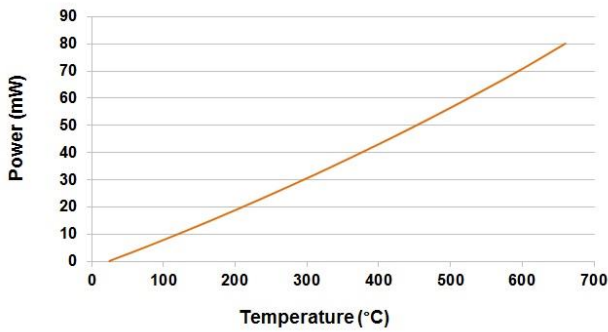
R_T (Track Resistance) = 12Ω ± 0.5Ω @ 25°C, $T_0 = 25^\circ\text{C}$
 $\alpha = 2.05 \times 10^{-3} \text{ K}^{-1}$, $\beta = 0.3 \times 10^{-6} \text{ K}^{-2}$

Note2

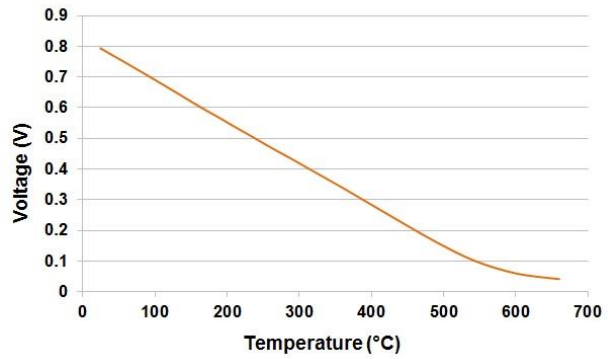
Without sensing material



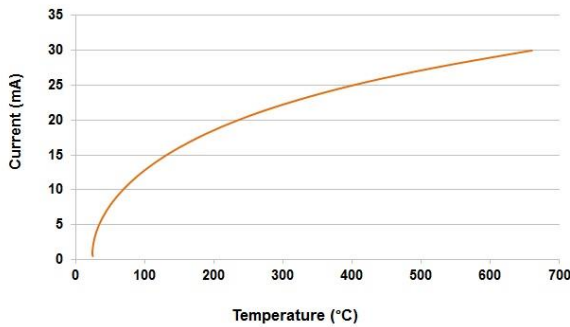
Power Consumption v Temperature



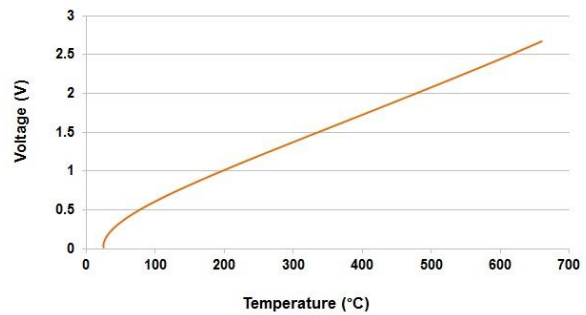
Diode characteristics



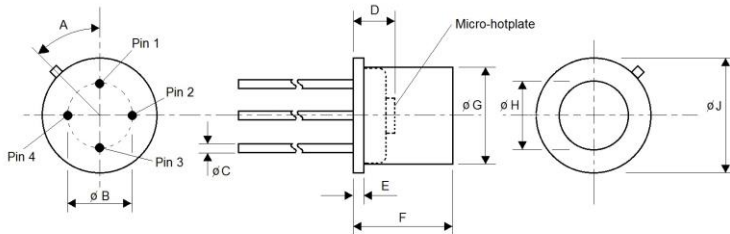
Current v Temperature



Voltage v Temperature

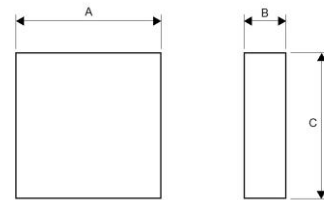


TO Package dimensions



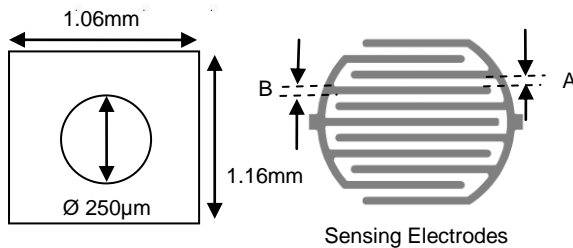
	A	B	C	D	E	F	G	H	J
TO39	45°	5.08	0.45	1.92	0.38	4.35	8.31	5.30	9.20
TO46	45°	2.54	0.45	1.55	0.25	2.70	4.70	2.55	5.40
Micro TO	-	1.80	0.30	1.28	0.38	2.30	3.10	1.80	4.10

SMD Package dimensions



	A	B	C
LCC	3.80	1.45	3.80
QFN	3.00	0.84	3.00

Various pin-outs available



Options	A(µm)	B(µm)	Thickness (nm)	Aspect Ratio
1	5	5	400	800
2	10	10	400	170

Measured Resistance = Material Sheet Resistance / Aspect Ratio

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